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With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



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AUTOMOTIVE GRADE

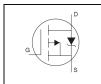
AUIRFR5305 AUIRFU5305

Features

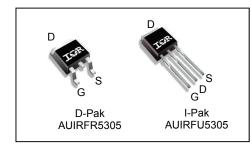
- Advanced Planar Technology
- Low On-Resistance
- Dynamic dv/dt Rating
- 175°C Operating Temperature
- Fast Switching
- Fully Avalanche Rated
- Repetitive Avalanche Allowed up to Tjmax
- Lead-Free, RoHS Compliant
- Automotive Qualified *



Specifically designed for Automotive applications, this Cellular Planar design of HEXFET® Power MOSFETs utilizes the latest processing techniques to achieve low on-resistance per silicon area. This benefit combined with the fast switching speed and ruggedized device design that HEXFET power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in Automotive and a wide variety of other applications.



V _{DSS}		-55V
R _{DS(on)}	max.	0.065Ω
I _D		-31A



G	D	S
Gate	Drain	Source

Base next number Deckage Type		Standard Pack		Ordershie Bort Number
Base part number	Package Type	Form Quantity		Orderable Part Number
AUIRFU5305	I-Pak	Tube	75	AUIRFU5305
ALUDEDESOE	D. Dok	Tube	75	AUIRFR5305
AUIRFR5305	D-Pak	Tape and Reel Left	3000	AUIRFR5305TRL

Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (TA) is 25°C, unless otherwise specified.

Symbol	Symbol Parameter		Units	
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ -10V	-31		
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ -10V	-22	Α	
I _{DM}	Pulsed Drain Current ① ⑥	-110		
$P_D @ T_C = 25^{\circ}C$	Maximum Power Dissipation	110	W	
	Linear Derating Factor	0.71	W/°C	
V_{GS}	Gate-to-Source Voltage	± 20	V	
E _{AS} Single Pulse Avalanche Energy (Thermally Limited) ②6		280	mJ	
I _{AR}	Avalanche Current ①⑥	-16	А	
E _{AR}	Repetitive Avalanche Energy ①	11	mJ	
dv/dt	Peak Diode Recovery dv/dt36	-5.0	V/ns	
TJ	Operating Junction and	-55 to + 175		
T_{STG}	Storage Temperature Range		°C	
	Soldering Temperature, for 10 seconds (1.6mm from case)	300		

Thermal Resistance

Symbol	Symbol Parameter		Max.	Units
$R_{ heta JC}$	Junction-to-Case		1.4	
$R_{\theta JA}$	Junction-to-Ambient (PCB Mount) ∅		50	°C/W
$R_{\theta JA}$	Junction-to-Ambient ®		110	

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^{*}Qualification standards can be found at www.infineon.com



Static @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	-55			V	$V_{GS} = 0V, I_{D} = -250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		-0.034		V/°C	Reference to 25°C, I_D = -1mA
R _{DS(on)}	Static Drain-to-Source On-Resistance			0.065	Ω	V _{GS} = -10V, I _D = -16A ④
$V_{GS(th)}$	Gate Threshold Voltage	-2.0		-4.0	V	$V_{DS} = V_{GS}$, $I_D = -250\mu A$
gfs	Forward Trans conductance	8.0			S	$V_{DS} = -25V, I_{D} = -16A $
	Drain-to-Source Leakage Current			-25		$V_{DS} = -55 \text{ V}, V_{GS} = 0 \text{ V}$
I _{DSS}	Dialii-to-Source Leakage Current			-250	μΑ	$V_{DS} = -44V, V_{GS} = 0V, T_{J} = 150^{\circ}C$
	Gate-to-Source Forward Leakage			-100	nΛ	$V_{GS} = -20V$
I _{GSS}	Gate-to-Source Reverse Leakage			100	nA	V _{GS} = 20V

Dynamic Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

•	•	-	-		
Q_g	Total Gate Charge	 	63		I _D = -16A
Q_{gs}	Gate-to-Source Charge	 	13	nC	$V_{DS} = -44V$
Q_{gd}	Gate-to-Drain Charge	 	29		V _{GS} = -10V, See Fig 6 and 13 ⊕ ®
$t_{d(on)}$	Turn-On Delay Time	 14			$V_{DD} = -28V$
t _r	Rise Time	 66		no	I _D = -16A
$t_{d(off)}$	Turn-Off Delay Time	 39		ns	$R_G = 6.8\Omega$
t _f	Fall Time	 63			$R_D = 1.6\Omega$, See Fig 10 \oplus \oplus
L _D	Internal Drain Inductance	 4.5			Between lead, 6mm (0.25in.)
L _S	Internal Source Inductance	 7.5			from package and center of die contact
C _{iss}	Input Capacitance	 1200			$V_{GS} = 0V$
Coss	Output Capacitance	 520		рF	$V_{DS} = -25V$
C _{rss}	Reverse Transfer Capacitance	 250			f = 1.0MHz, See Fig. 56

Diode Characteristics

	Parameter	Min.	Тур.	Max.	Units	Conditions
I _S	Continuous Source Current (Body Diode)			-31		MOSFET symbol showing the
I _{SM}	Pulsed Source Current (Body Diode) ①			-110		integral reverse p-n junction diode.
V_{SD}	Diode Forward Voltage			-1.3	V	$T_J = 25^{\circ}C, I_S = -16A, V_{GS} = 0V $ ④
t _{rr}	Reverse Recovery Time		71	110	ns	$T_J = 25^{\circ}C$, $I_F = -16A$
Qrr	Reverse Recovery Charge		170	250	nC	di/dt = 100A/µs ④⑥

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)
- ② V_{DD} = -25V, starting T_J = 25°C, L = 2.1mH, R_G = 25 Ω , I_{AS} = -16A. (See Fig.12)
- $\exists \quad I_{SD} \leq -16A, \ di/dt \leq -280A/\mu s, \ V_{DD} \leq V_{(BR)DSS}, \ T_J \leq 175^{\circ}C.$
- 4 Pulse width $\leq 300 \mu s$; duty cycle $\leq 2\%$.
- ⑤ This is applied for I-PAK, L_S of D-PAK is measured between lead and center of die contact .
- © Uses IRF5305 data and test conditions.
- When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994

® Uses typical socket mount.



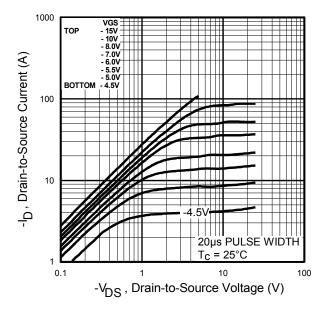


Fig. 1 Typical Output Characteristics

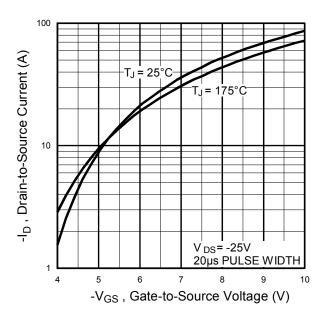


Fig. 3 Typical Transfer Characteristics

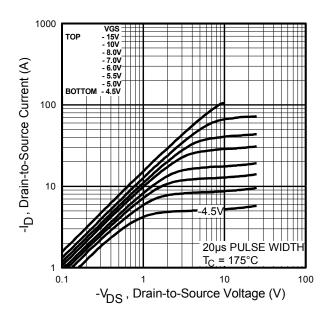


Fig. 2 Typical Output Characteristics

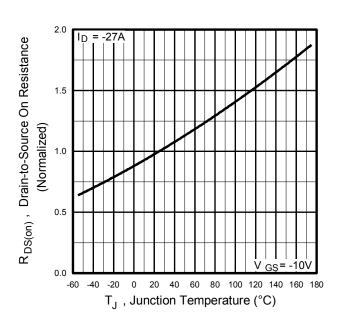


Fig. 4 Normalized On-Resistance vs. Temperature



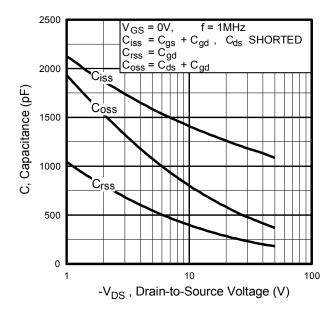


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

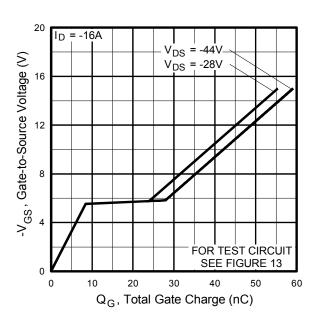


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage

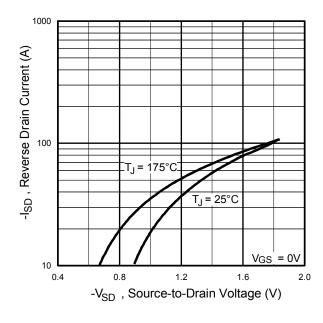


Fig. 7 Typical Source-to-Drain Diode Forward Voltage

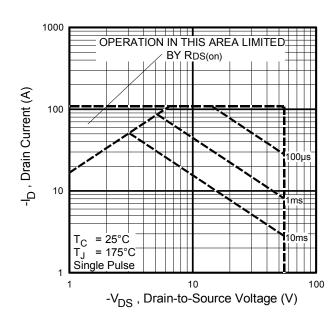


Fig 8. Maximum Safe Operating Area



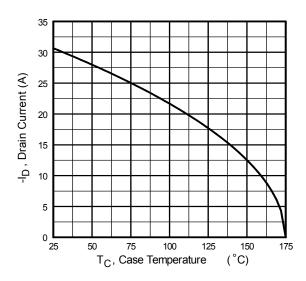


Fig 9. Maximum Drain Current vs. Case Temperature

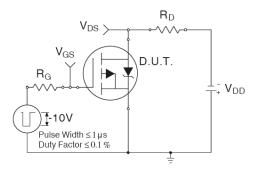


Fig 10a. Switching Time Test Circuit

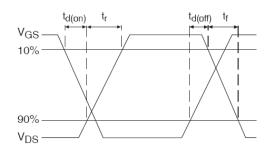


Fig 10b. Switching Time Waveforms

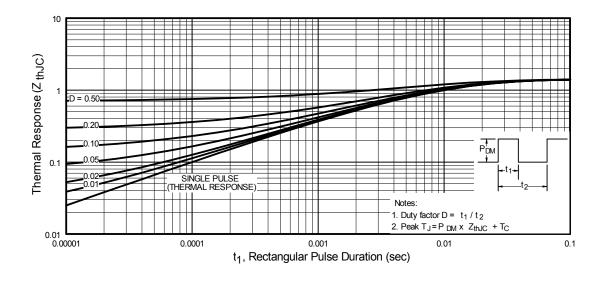


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case



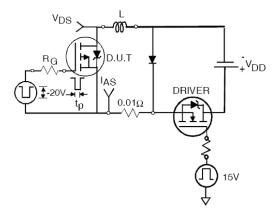


Fig 12a. Unclamped Inductive Test Circuit

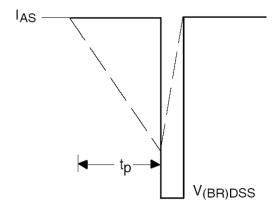


Fig 12b. Unclamped Inductive Waveforms

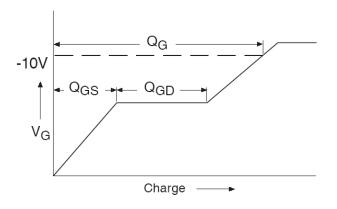


Fig 13a. Gate Charge Waveform

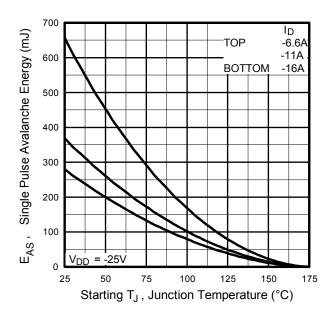


Fig 12c. Maximum Avalanche Energy vs. Drain Current

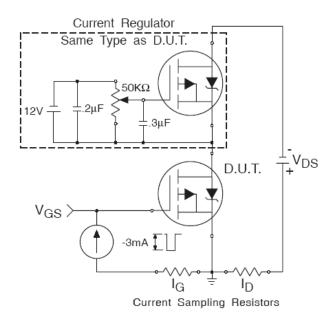
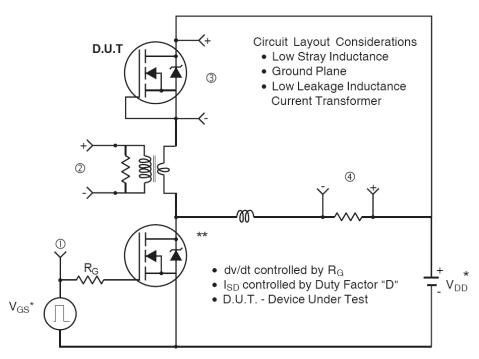


Fig 13b. Gate Charge Test Circuit

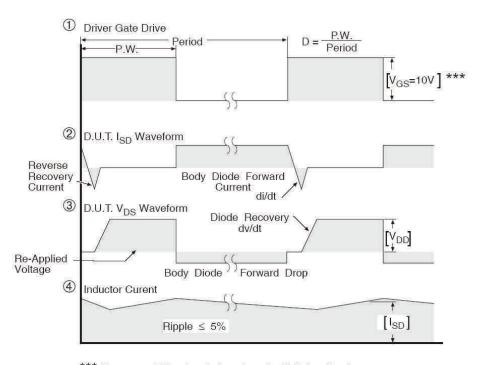


Peak Diode Recovery dv/dt Test Circuit



^{*} Reverse Polarity for P-Channel

^{**} Use P-Channel Driver for P-Channel Measurements



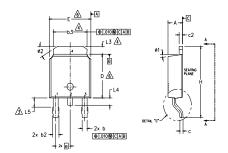
*** $V_{GS} = 5.0V$ for Logic Level and 3V Drive Devices

Fig 14. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

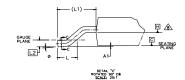
2015-10-12

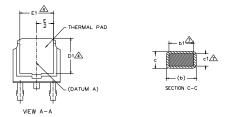


D-Pak (TO-252AA) Package Outline (Dimensions are shown in millimeters (inches))









NOTES:

- 1.- DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2.- DIMENSION ARE SHOWN IN INCHES [MILLIMETERS].
- LEAD DIMENSION UNCONTROLLED IN L5.
- A- DIMENSION D1, E1, L3 & b3 ESTABLISH A MINIMUM MOUNTING SURFACE FOR THERMAL PAD.
- 5.— SECTION C-C DIMENSIONS APPLY TO THE FLAT SECTION OF THE LEAD BETWEEN .005 AND 0.10 [0.13 AND 0.25] FROM THE LEAD TIP.
- Limited Dimension D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005 [0.13] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.
- A- DIMENSION 61 & c1 APPLIED TO BASE METAL ONLY.
- ♠ DATUM A & B TO BE DETERMINED AT DATUM PLANE H.
- 9.- OUTLINE CONFORMS TO JEDEC OUTLINE TO-252AA.

S Y M	DIMENSIONS					
B	MILLIM	ETERS	INC	HES	O T E S	
L	MIN.	MAX.	MIN.	MAX.	S	
Α	2.18	2.39	.086	.094		
A1	-	0.13	-	.005		
b	0.64	0.89	.025	.035		
ь1	0.65	0.79	.025	.031	7	
b2	0.76	1.14	.030	.045		
b3	4.95	5.46	.195	.215	4	
С	0.46	0.61	.018	.024		
с1	0.41	0.56	.016	.022	7	
c2	0.46	0.89	.018	.035		
D	5.97	6.22	.235	.245	6	
D1	5.21	-	.205	-	4	
Ε	6.35	6.73	.250	.265	6	
E1	4.32	-	.170	-	4	
е	2.29	BSC	.090	BSC		
Н	9.40	10.41	.370	.410		
L	1.40	1.78	.055	.070		
L1	2.74	BSC	.108	REF.		
L2	0.51	BSC	.020	BSC		
L3	0.89	1.27	.035	.050	4	
L4	-	1.02	-	.040		
L5	1.14	1.52	.045	.060	3	
ø	0,	10*	0,	10°		
ø1	0,	15*	0,	15*		
ø2	25*	35°	25*	35°		

LEAD ASSIGNMENTS

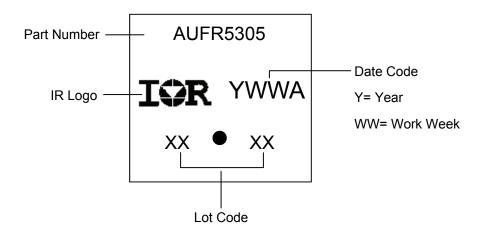
HEXFET

- 1.- GATE
- 2.- DRAIN
- 3.- SOURCE
- 4.- DRAIN

IGBT & CoPAK

- 1.- GATE
- 2.- COLLECTOR
- 3.- EMITTER 4.- COLLECTOR

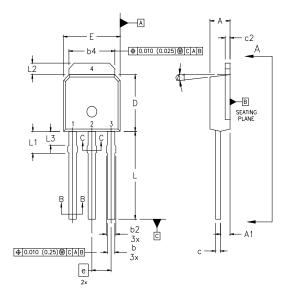
D-Pak (TO-252AA) Part Marking Information

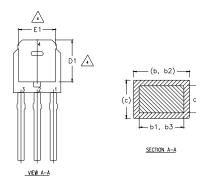


Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



I-Pak (TO-251AA) Package Outline (Dimensions are shown in millimeters (inches)





NOTES:

SYMBOL

- 1 DIMENSIONING AND TOLERANCING PER ASME Y14.5 M- 1994.
- 2 DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
- 3 DIMENSION D & E DO NOT INCLUDE MOLD FLASH, MOLD FLASH SHALL NOT EXCEED 0.005" (0.127) PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- 4 THERMAL PAD CONTOUR OPTION WITHIN DIMENSION 64, L2, E1 & D1.

INCHES

.094

0.086

NOTES

LEAD DIMENSION UNCONTROLLED IN L3.

2.39

- 6 DIMENSION 61, 63 APPLY TO BASE METAL ONLY.
 - OUTLINE CONFORMS TO JEDEC OUTLINE TO-251AA.

DIMENSIONS

8 CONTROLLING DIMENSION : INCHES.

MILLIMETERS

MIN.

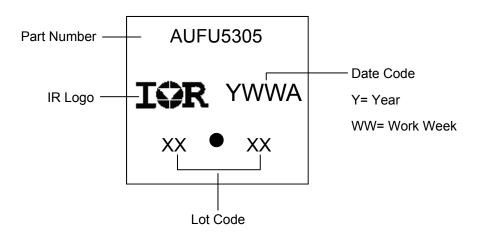
2.18

LEAD ASSIGNMENTS

HEXFET

- 1.- GATE
- 2.- DRAIN 3.- SOURCE
- 3.- SOURC4.- DRAIN
- A1 0.89 1.14 0.035 0.045 b 0.64 0.89 0.025 0.035 ь1 0.64 0.79 0.025 0.031 b2 0.76 1.14 0.030 0.045 0.76 1.04 0.030 0.041 5.00 5.46 0.195 0.215 b4 0.46 0.61 0.018 0.024 0.016 0.41 0.56 0.022 c1 c2 .046 0.86 0.018 0.035 D 5.97 6.22 0.235 0.245 D1 5.21 0.205 6.35 6.73 0.250 0.265 E1 4.32 0.170 0.090 BSC е L 8.89 9.60 0.350 0.380 L1 1,91 2.29 0.075 0.090 L2 0.89 1.27 0.035 0.050 L3 1.14 1.52 0.045 0.060 15*

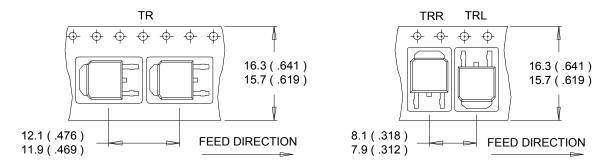
I-Pak (TO-251AA) Part Marking Information



Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

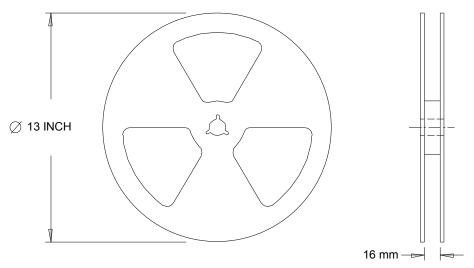


D-Pak (TO-252AA) Tape & Reel Information (Dimensions are shown in millimeters (inches))



NOTES:

- 1. CONTROLLING DIMENSION: MILLIMETER.
- 2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS (INCHES).
- 3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



NOTES:

1. OUTLINE CONFORMS TO EIA-481.

Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



Qualification Information

		Automotive (per AEC-Q101)				
			(per AEC-Q101)			
Qualification Level		Comments: This part number(s) passed Automotive qualification. Infineon's Industrial and Consumer qualification level is granted by extension of the higher Automotive level.				
Moisture Sensitivity Level		D-Pak	MOL 4			
		I-Pak	MSL1			
	Machine Madel	Class M2 (+/- 200V) [†]				
	Machine Model	AEC-Q101-002				
50 D	Harris Dada Madal	Class H1B (+/- 1000V) [†]				
ESD	Human Body Model	AEC-Q101-001				
	Observed Davis Madal	Class C5 (+/- 1125V) [†]				
Charged Device Model		AEC-Q101-005				
RoHS Compliant		Yes				

[†] Highest passing voltage.

Revision History

Date	Comments			
10/12/2015	Updated datasheet with corporate template			
10/12/2015	Corrected ordering table on page 1.			

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